

**Search Notes**

Application/Control No.

10/804,082

Examiner

John L. Goodrow

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

1756

**SEARCHED**

Class	Subclass	Date	Examiner
430	137.15	2/19/2007	JG
	137.17		
	109.4		
	110.3		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR